

STARPOWER

SEMICONDUCTOR

SiC MOSFET

MD29HTS120P6HET

1200V/2.90mΩ 6 in one-package

General Description

STARPOWER SiC MOSFET Power Module provides very low $R_{DS(on)}$ as well as high blocking voltage.

It's designed for the applications such as hybrid and electric vehicle.

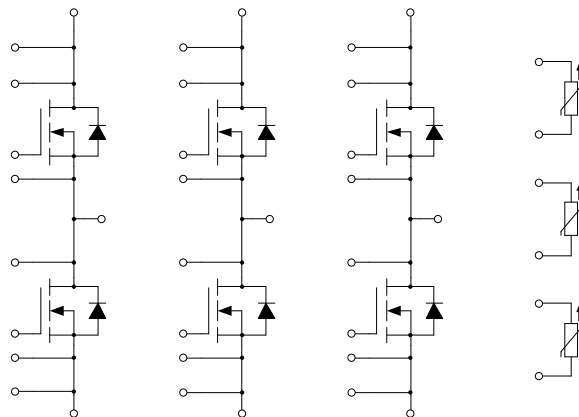
Features

- SiC power MOSFET
- High blocking voltage with low $R_{DS(on)}$
- Easy to parallel and simple to drive
- Low inductance case avoid oscillations
- Isolated copper pinfin baseplate using Si_3N_4 AMB technology

Typical Applications

- Automotive application
- Hybrid and electric vehicle
- Inverter for motor drive

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_F=25^{\circ}\text{C}$ unless otherwise noted**MOSFET**

Symbol	Description	Value	Unit
V_{DSS}	Drain-Source Voltage	1200	V
V_{GSSmax}	Gate-Source Voltage	-8/+19	V
V_{GSSop}	Gate-Source Voltage	-4/+15	V
I_D	Drain Current @ $T_F=60^{\circ}\text{C}$	445	A
I_{DM}	Pulsed Drain Current, t_p limited by T_{vjmax}	890	A
P_D	Maximum Power Dissipation @ $T_F=60^{\circ}\text{C}$ $T_{vj}=175^{\circ}\text{C}$	982	W

Body Diode

Symbol	Description	Value	Unit
I_S	Source Current @ $T_F=60^{\circ}\text{C}$	268	A

Module

Symbol	Description	Value	Unit
T_{vjmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{vjop}	Operating Junction Temperature	-40 to +175	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	3000	V
d_{Creep}	Terminal to Heatsink	9.0	mm
	Terminal to Terminal	9.0	
d_{Clear}	Terminal to Heatsink	4.5	mm
	Terminal to Terminal	4.5	

MOSFET Characteristics $T_F=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit	
$R_{DS(on)}$	Static Drain-Source On-Resistance	$I_D=450\text{A}, V_{GS}=15\text{V}, T_{vj}=25^\circ\text{C}$		2.90		m Ω	
		$I_D=450\text{A}, V_{GS}=15\text{V}, T_{vj}=150^\circ\text{C}$		4.40			
		$I_D=450\text{A}, V_{GS}=15\text{V}, T_{vj}=175^\circ\text{C}$		4.85			
$V_{GS(th)}$	Gate-Source Threshold Voltage	$I_D=125\text{mA}, V_{DS}=V_{GS}, T_{vj}=25^\circ\text{C}$		3.10		V	
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=V_{DSS}, V_{GS}=0\text{V}, T_{vj}=25^\circ\text{C}$			500	μA	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=19\text{V}, V_{DS}=0\text{V}, T_{vj}=25^\circ\text{C}$			600	nA	
R_{Gint}	Internal Gate Resistance			1.07		Ω	
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=800\text{V}, f=100\text{kHz}$		37.5		nF	
C_{oss}	Output Capacitance			2.22		nF	
C_{rss}	Reverse Transfer Capacitance			0.12		nF	
Q_g	Total Gate Charge	$I_D=450\text{A}, V_{DS}=800\text{V}, V_{GS}=-4/15\text{V}$		1.00		μC	
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=800\text{V}, I_D=450\text{A}, R_{Gon}=5.1\Omega, R_{Goff}=3.3\Omega, L_S=21\text{nH}, V_{GS}=-4/15\text{V}, T_{vj}=25^\circ\text{C}$		111		ns	
t_r	Rise Time			84		ns	
$t_{d(off)}$	Turn-Off Delay Time			183		ns	
t_f	Fall Time			37		ns	
E_{on}	Turn-On Switching Loss	$L_S=21\text{nH}, V_{GS}=-4/15\text{V}, T_{vj}=25^\circ\text{C}$		28.8		mJ	
E_{off}	Turn-Off Switching Loss			12.7		mJ	
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=800\text{V}, I_D=450\text{A}, R_{Gon}=5.1\Omega, R_{Goff}=3.3\Omega, L_S=21\text{nH}, V_{GS}=-4/15\text{V}, T_{vj}=150^\circ\text{C}$		143		ns	
t_r	Rise Time			85		ns	
$t_{d(off)}$	Turn-Off Delay Time			272		ns	
t_f	Fall Time			42		ns	
E_{on}	Turn-On Switching Loss			29.9		mJ	
E_{off}	Turn-Off Switching Loss			15.4		mJ	
$t_{d(on)}$	Turn-On Delay Time		$V_{DS}=800\text{V}, I_D=450\text{A}, R_{Gon}=5.1\Omega, R_{Goff}=3.3\Omega, L_S=21\text{nH}, V_{GS}=-4/15\text{V}, T_{vj}=175^\circ\text{C}$		144		ns
t_r	Rise Time				86		ns
$t_{d(off)}$	Turn-Off Delay Time			293		ns	
t_f	Fall Time			43		ns	
E_{on}	Turn-On Switching Loss			30.5		mJ	
E_{off}	Turn-Off Switching Loss			15.9		mJ	

Body Diode Characteristics $T_F=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_{SD}	Diode Forward Voltage	$I_{SD}=220\text{A}, V_{GS}=-4\text{V}, T_{vj}=25^\circ\text{C}$		4.15		V
		$I_{SD}=220\text{A}, V_{GS}=-4\text{V}, T_{vj}=175^\circ\text{C}$		3.60		
Q_r	Diode Reverse Recovery Charge	$V_R=800\text{V}, I_{SD}=450\text{A}, -di/dt=5500\text{A}/\mu\text{s}, L_S=21\text{nH}, V_{GS}=-4\text{V}, T_{vj}=25^\circ\text{C}$		1.85		μC
I_{rrm}	Peak Reverse Recovery Current			94		A
E_{rec}	Reverse Recovery Energy			0.28		mJ
Q_r	Diode Reverse Recovery Charge	$V_R=800\text{V}, I_{SD}=450\text{A}, -di/dt=6070\text{A}/\mu\text{s}, L_S=21\text{nH}, V_{GS}=-4\text{V}, T_{vj}=150^\circ\text{C}$		5.53		μC
I_{rrm}	Peak Reverse Recovery Current			171		A
E_{rec}	Reverse Recovery Energy			1.08		mJ
Q_r	Diode Reverse Recovery Charge	$V_R=800\text{V}, I_{SD}=450\text{A}, -di/dt=6100\text{A}/\mu\text{s}, L_S=21\text{nH}, V_{GS}=-4\text{V}, T_{vj}=175^\circ\text{C}$		6.35		μC
I_{rrm}	Peak Reverse Recovery Current			185		A
E_{rec}	Reverse Recovery Energy			1.23		mJ

NTC Characteristics $T_F=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_1=100^\circ\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
L_{CE}	Stray Inductance		8		nH
$R_{CC'+EE'}$	Module Lead Resistance, Terminal to Chip		0.43		m Ω
p	Maximum Pressure In Cooling Circuit			2.5	bar
R_{thJF}	Junction-to-Cooling Fluid (per MOSFET) $\Delta V/\Delta t=10.0\text{dm}^3/\text{min}, T_F=60^{\circ}\text{C}$		0.117	0.129	K/W
M	Terminal Connection Torque, Screw M5 Mounting Torque, Screw M4	3.6 1.8		4.4 2.2	N.m
G	Weight of Module		792		g

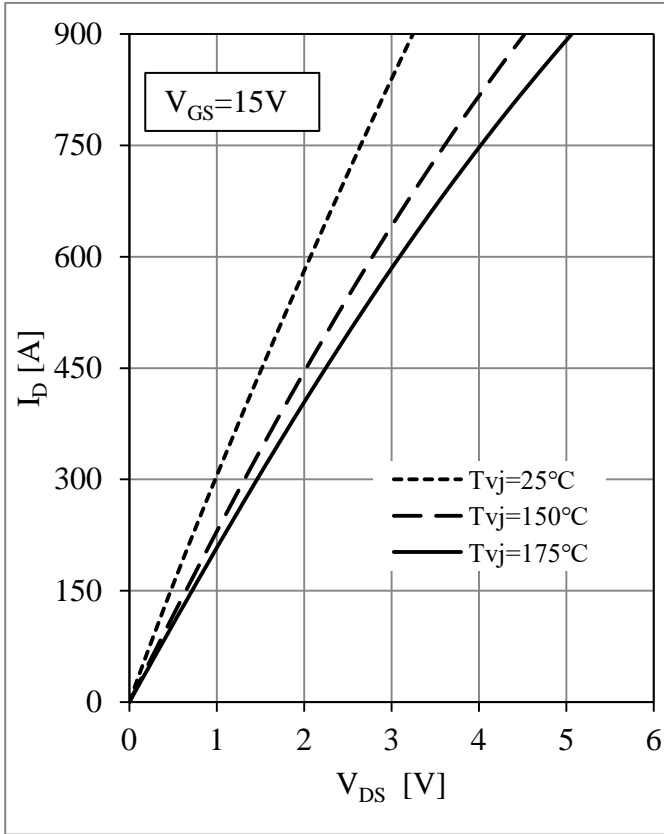


Fig 1. MOSFET Output Characteristics

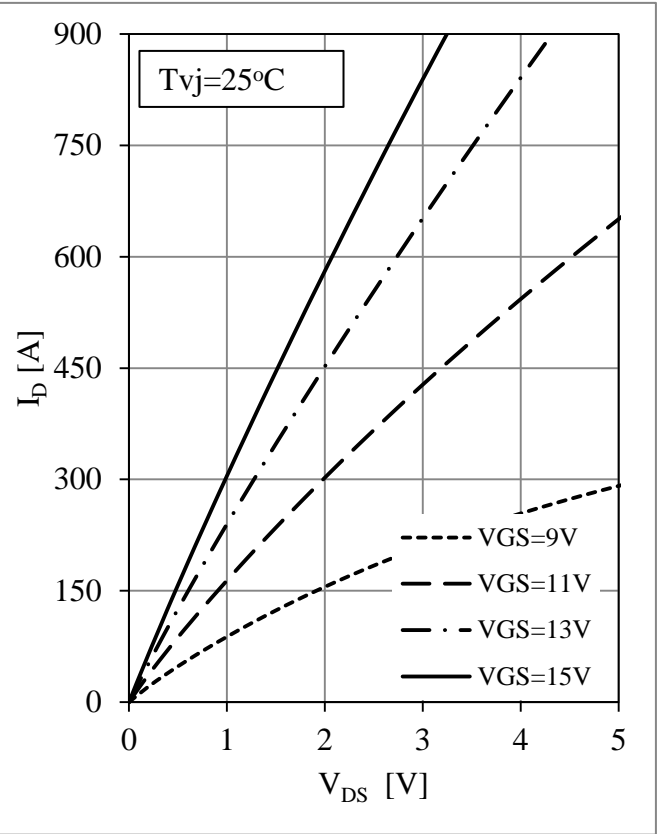


Fig 2. MOSFET Output Characteristics

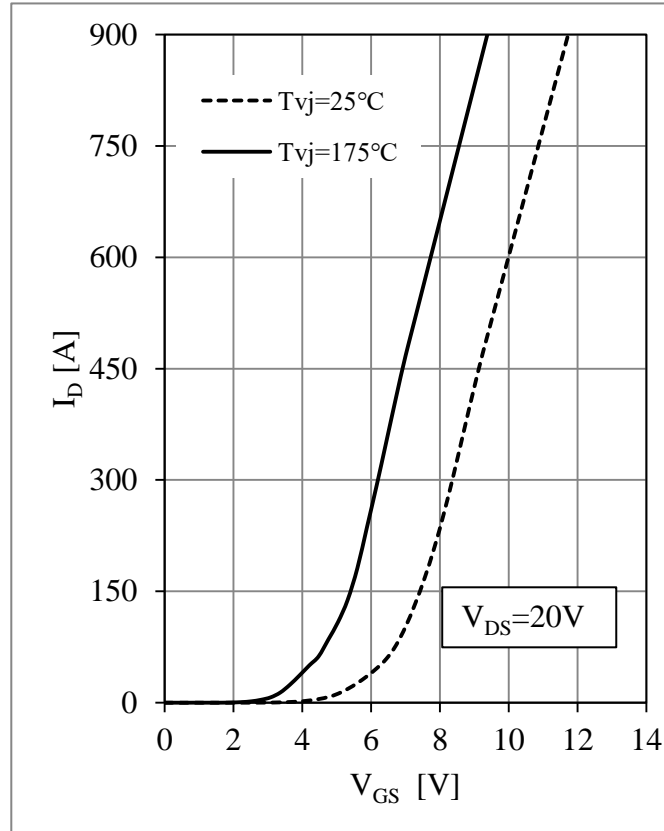


Fig 3. MOSFET Transfer Characteristics

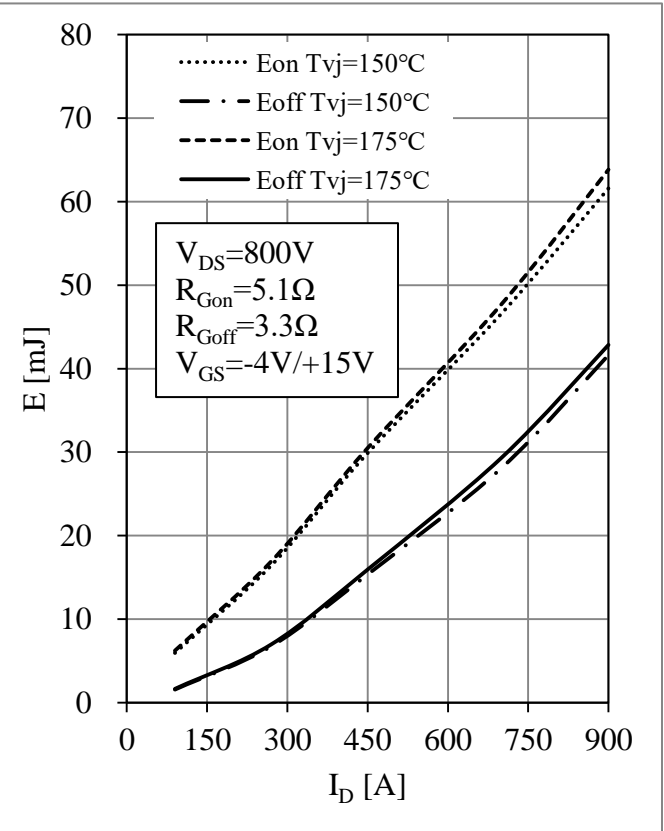


Fig 4. MOSFET Switching Loss vs. I_{DS}

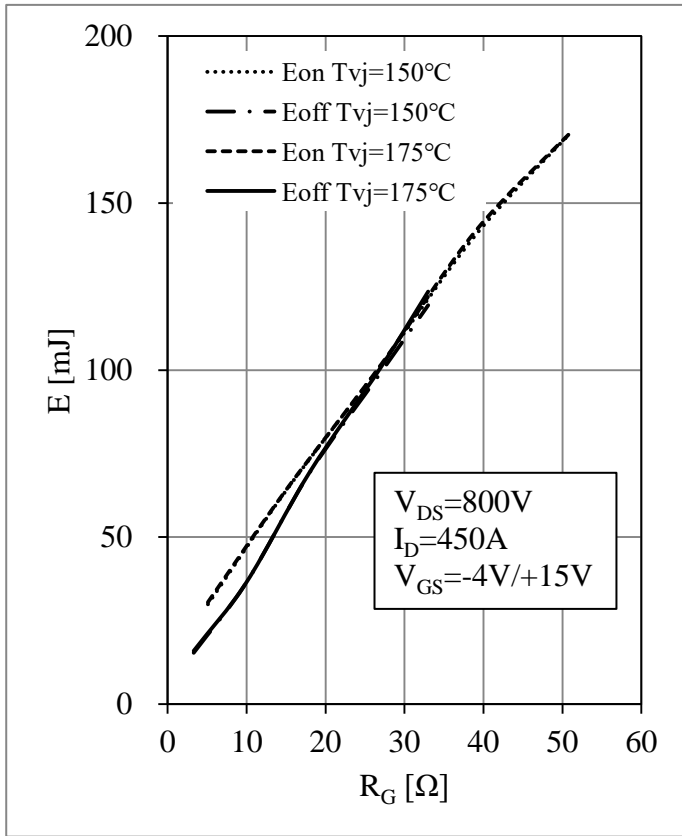


Fig 5. MOSFET Switching Loss vs. R_G

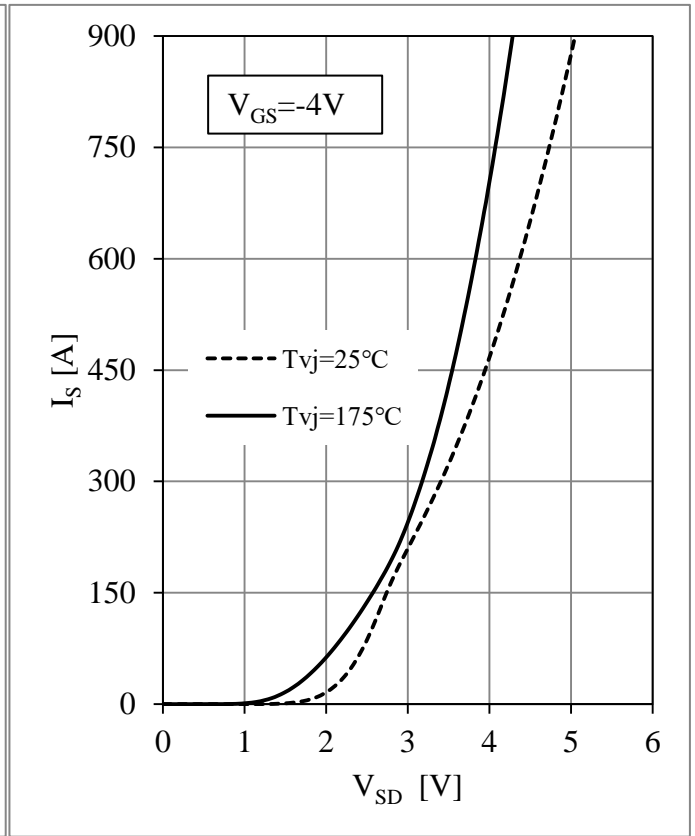


Fig 6. Body Diode Characteristics

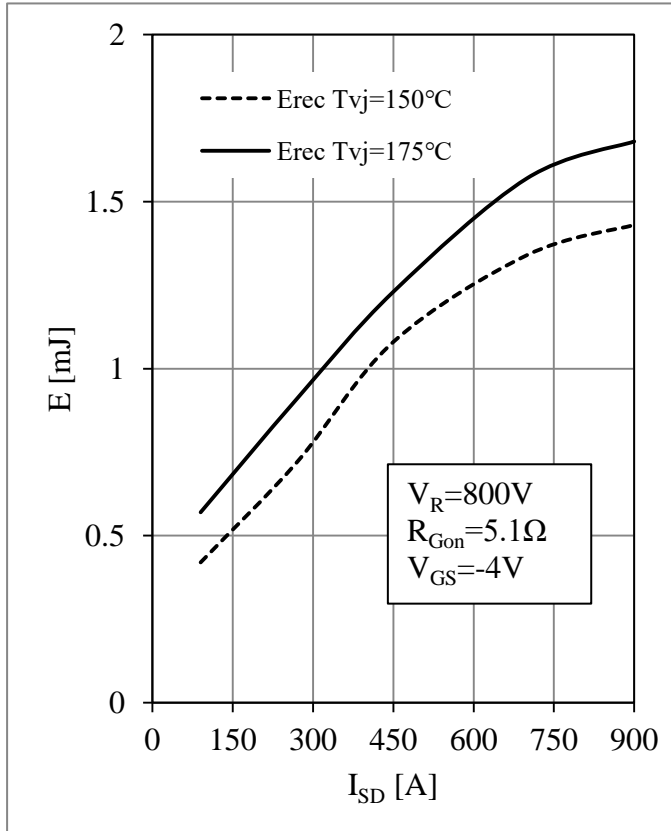


Fig 7. Body Diode Switching Loss vs. I_S

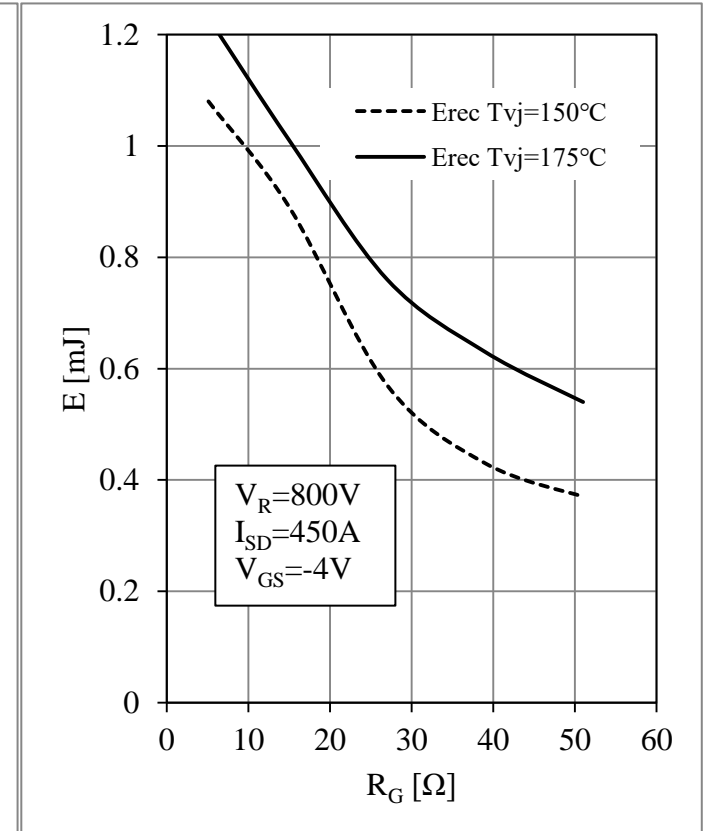


Fig 8. Body Diode Switching Loss vs. R_G

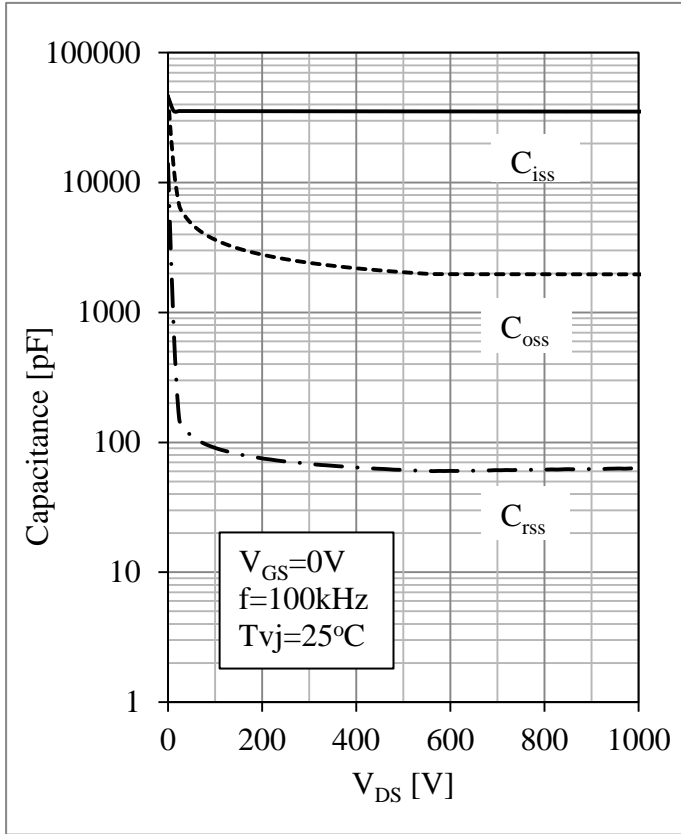


Fig 9. Capacitance vs. V_{DS}

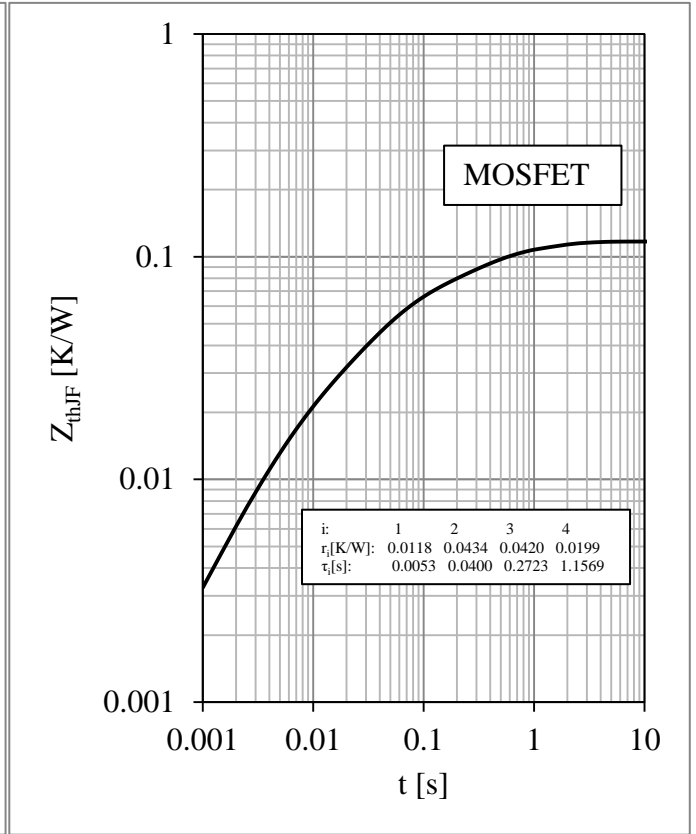


Fig 10. MOSFET Transient Thermal Impedance

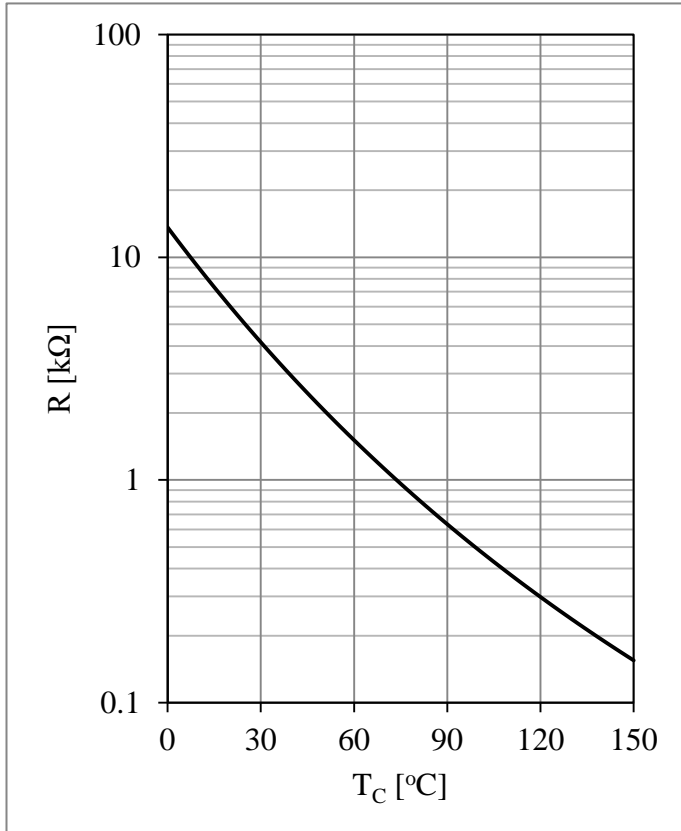
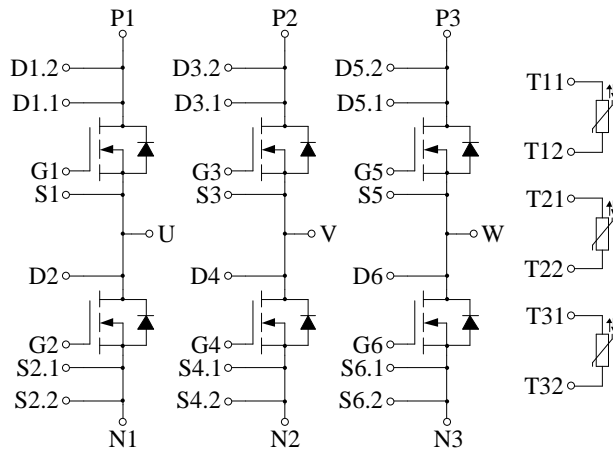


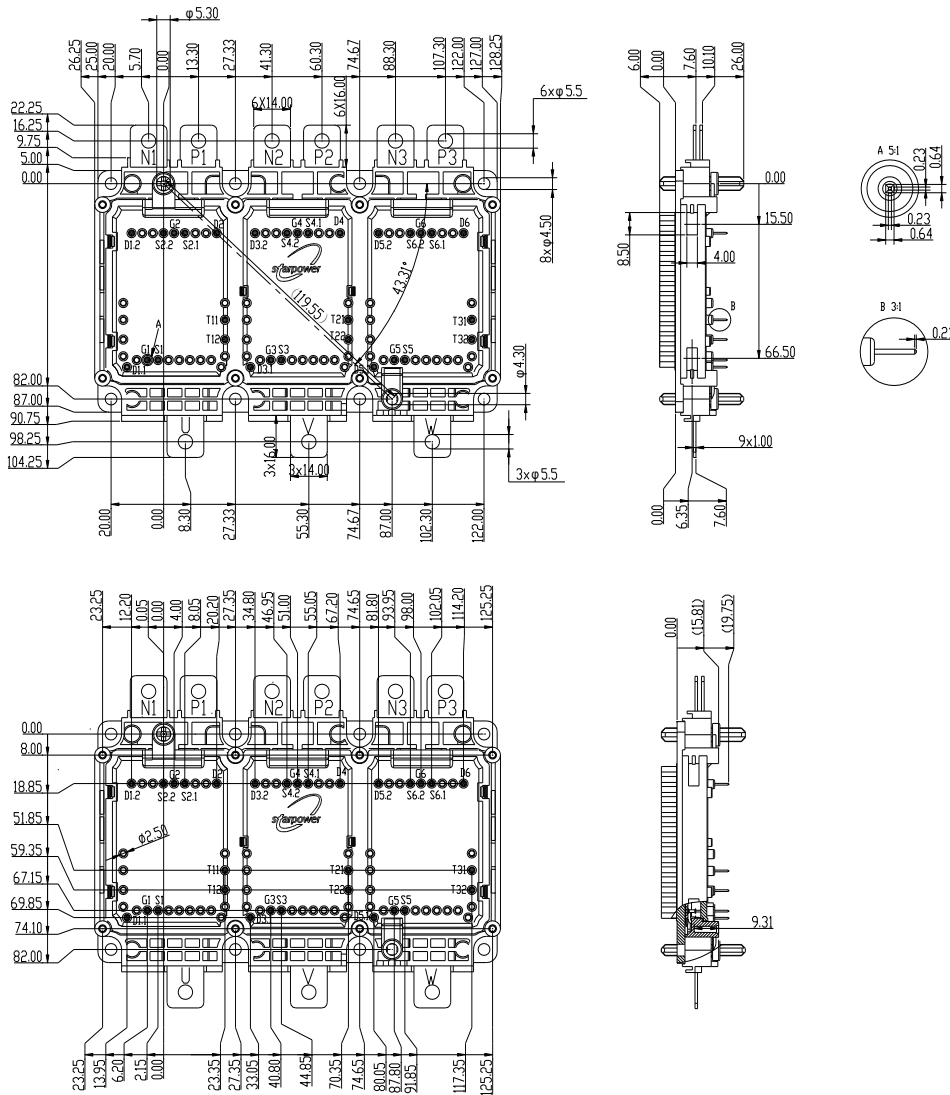
Fig 11. NTC Temperature Characteristic

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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